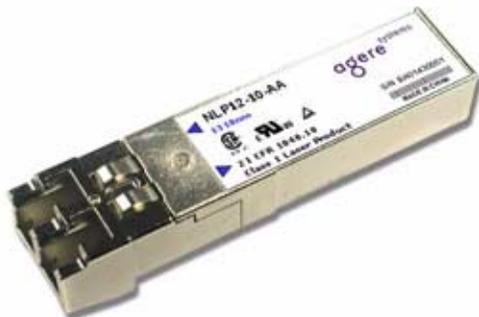


NetLight[®] NLP12 Small Form-Factor Pluggable (SFP) Gigabit Ethernet Laser Transceiver



Available in a small form factor, LC Receptacle connector metal package, the NLP12 SFP Transceiver is a high-performance, cost-effective, optical transceiver for Gigabit Ethernet applications.

Features

- Multisource agreement (MSA) compliant SFP package
- LC duplex receptacle
- Metal package for superior EMI performance
- 1300 nm FP laser transmitter with automatic output power control (1000BASE-LX version)
- 850 nm VCSEL laser transmitter with automatic output power control (1000BASE-SX version)
- Transmitter disable input
- Hot-pluggable electrical interface
- Wide dynamic range
- TTL signal-detect output
- Low power dissipation
- Single 3.3 V power supply
- ac-coupled data inputs and outputs
- Operating temperature range of 0 °C to 85 °C (1000BASE-LX only)
- Serial identification (EEPROM)

Benefits

- Upgrade path:
 - OEMs can offer longer-reach and higher-speed solutions, as the end user needs upgrades.

Applications

- IEEE[®] 802.3z 1000BASE-LX
- IEEE 802.3z 1000BASE-SX

Description

The NLP12 small form-factor pluggable (SFP) transceiver is a high-speed, cost effective optical transceiver that is intended for 1.25 Gbits/s Gigabit Ethernet 1000BASE-LX and 1000BASE-SX applications. The transceiver features Agere Systems' optics and is packaged in a narrow-width metal housing with an LC duplex receptacle. This receptacle fits into an RJ-45 form factor outline. The SFP package pinout conforms to a multisource SFP transceiver agreement.

The transmitter features ac-coupled differential data inputs. The transmitter also features a TTL logic level disable input and a transmitter fault indicator output. The receiver features differential ac-coupled data outputs and a TTL logic level loss-of-signal output.

Absolute Maximum Ratings

Stresses in excess of the absolute maximum ratings can cause permanent damage to the device. These are absolute stress ratings only. Functional operation of the device is not implied at these or any other conditions in excess of those given in the operations sections of the data sheet. Exposure to absolute maximum ratings for extended periods can adversely affect device reliability.

Parameter	Symbol	Min	Max	Unit
Storage Temperature Range	T _{stg}	-40	85	°C
Case Temperature Range	T _c	0	85	°C
Supply Voltage	V _{ccT, R}	0	3.8	V

NLP12-10-AA, 1300 nm FP

Table 1. Recommended Operating Conditions

Parameter	Symbol	Min	Typ	Max	Unit
Case Temperature Range	T _c	0	—	85	°C
Supply Voltage	V _{ccT, R}	3.135	—	3.465	V
Data Rate	—	—	1.25	—	Gbits/s

NLP12-10-AA 1300 nm FP (continued)

Transceiver Optical and Electrical Characteristics

Table 2. Transmitter Optical and Electrical Characteristics (TC = 0 °C to 85 °C, VCC = 3.135 V—3.465 V)

Parameter	Symbol	Min	Max	Unit
Optical Output Power: Average	PO	-9.5	-3	dBm
Disabled	PO DIS	-	-35	dBm
Optical Wavelength	λ_C	1285	1343	nm
Spectral Width	$\Delta\lambda_{RMS}$	—	2.8	nm
Dynamic Extinction Ratio	EXT	9	—	dB
Optical Output Rise/Fall Time (20%–80%)	tR/tF	—	260	ps
Total Transmitter Jitter added at TP2 ¹	TJ	—	227	ps
Relative Intensity Noise	RIN	-	-120	db/Hz
Power Supply Current	ICCT	—	150	mA
Input Data Voltage—Differential ²	VINp-p	300	1600	mVp-p
Transmit Disable Voltage ³	VD	VCC - 1.3	VCC	V
Transmit Enable Voltage ³	VEN	VEE	VEE + 0.8	V
Transmit Disable Assert Time ⁴	t_off	—	10	μ s
Transmit Disable Negate Time ⁵	t_on	—	1	ms
Transmit Fault Output Voltage Level	VFAULTH VFAULTL	VCC - 1.3 0	VCC 0.5	V V
Transmit Fault Assert Time ⁶	t_fault	—	100	μ s
Transmit Fault Reset Time ⁷	t_reset	10	—	μ s

1. TP2 refers to compliance point specified in 802.3z, section 38.2.1.

2. Differential operation is necessary for optimum performance.

3. TTL compatible interface.

4. Time from rising edge of Tx_Disable to when the optical output falls below 10% of nominal.

5. Time from falling edge of Tx_Disable to when the modulated optical output rises above 90% of nominal.

6. Time from fault to Tx_Fault on.

7. Time Tx_Disable must be held high to reset Tx_Fault.

NLP12-10-AA, 1300 nm FP (continued)

Transceiver Optical and Electrical Characteristics (continued)

Table 3. Receiver Optical and Electrical Characteristics (Tc = 0 °C to 85 °C, Vcc = 3.135 V—3.465 V)

Parameter	Symbol	Min	Max	Unit
Average Sensitivity ¹	PI	—	–20	dBm
Stressed Receiver Sensitivity ²	PSTRESS	—	–14.4	dBm
Maximum Input Power ¹	P _{MAX}	–3	—	dBm
Optical Return Loss	ORL	12	—	dB
Power Supply Current	I _{CCR}	—	150	mA
Power Supply Noise Rejection Ratio	PSNR	—	100	mV
Output Data—Differential ³	V _{OUTp-p}	400	1200	mVp-p
Data Output Rise/Fall Time	t _R /t _F	—	175	ps
Loss-of-Signal Voltage Level	V _{LOSH}	V _{CC} – 1.3	V _{CC}	V
	V _{LOSL}	0	0.8	V
Loss-of-Signal Assert Time ⁴	t _{loss_on}	—	100	μs
Loss-of-Signal Deassert Time ⁵	t _{loss_off}	—	100	μs
Loss-of-Signal Assert	P _{LOSA}	–34	–20.5	dBm
	P _{LOSD}	–34	–20	dBm
LOS Hysteresis	PHYS	0.5	6	dB

1. 2⁷ – 1 PRBS with a BER of 1 x 10⁻¹².

2. The stressed receiver sensitivity is measured using the conformance test signal defined in 802.3z, section 38.6.11.

3. Differential operation is necessary for optimum performance.

4. Time from LOS state to Rx LOS assert.

5. Time from nonLOS state to Rx LOS deassert.

NLP12-01-AA, 850 nm VCSEL

Table 4. Recommended Operating Conditions

Parameter	Symbol	Min	Typ	Max	Unit
Case Temperature Range	T _C	0	—	70	°C
Supply Voltage	V _{CC} T, R	3.135	—	3.465	V
Data Rate	—	—	1.25	—	Gbits/s

Transceiver Optical and Electrical Characteristics

Table 5. Transmitter Optical and Electrical Characteristics (T_C = 0° C to 70° C, V_{CC} = 3.135 V – 3.465 V)

Parameter	Symbol	Min	Max	Unit
Optical Output Power: Average	P _O	-9.5	0	dBm
Disabled	P _O DIS	—	-35	dBm
Optical Wavelength	λ _C	830	850	nm
Spectral Width	Δλ _{RMS}	—	0.85	nm
Dynamic Extinction Ratio	EXT	9	—	dB
Optical Output Rise/Fall Time (20%–80%)	t _R /t _F	—	260	ps
Total Transmitter Jitter added at TP2 ¹	T _J	—	227	ps
Relative Intensity Noise	RIN	—	-117	db/Hz
Power Supply Current	I _{CC} T	—	150	mA
Input Data Voltage—Differential ²	V _{INp-p}	300	1600	mVp-p
Transmit Disable Voltage ³	V _D	V _{CC} – 1.3	V _{CC}	V
Transmit Enable Voltage ³	V _{EN}	0	0.8	V
Transmit Disable Assert Time ⁴	t _{off}	—	10	μs
Transmit Disable Negate Time ⁵	t _{on}	—	1	ms
Transmit Fault Output Voltage Level	V _{FAULTH} V _{FAULTL}	V _{CC} – 1.3 0	V _{CC} 0.8	V V
Transmit Fault Assert Time ⁶	t _{fault}	—	100	μs
Transmit Fault Reset Time ⁷	t _{reset}	10	—	μs

1. TP2 refers to compliance point specified in 802.3z, section 38.2.1.

2. Differential operation is necessary for optimum performance.

3. TTL compatible interface.

4. Time from rising edge of Tx_Disable to when the optical output falls below 10% of nominal.

5. Time from falling edge of Tx_Disable to when the modulated optical output rises above 90% of nominal.

6. Time from fault to Tx_Fault on.

7. Time Tx_Disable must be held high to reset Tx_Fault.

NLP12-01-AA, 850 nm VCSEL (continued)

Transceiver Optical and Electrical Characteristics (continued)

Table 6. Receiver Optical and Electrical Characteristics (T_C = 0° C to 70° C, V_{CC} = 3.135 V – 3.465 V)

Parameter	Symbol	Min	Max	Unit
Average Sensitivity ¹	P _I	—	-17	dBm
Stressed Receiver Sensitivity: ² 62.5 μm Fiber	P _{STRESS}	—	-12.5	dBm
50 μm Fiber	P _{STRESS}	—	-13.5	dBm
Maximum Input Power ¹	P _{MAX}	0	—	dBm
Optical Return Loss	ORL	12	—	dB
Power Supply Current	I _{CCR}	—	150	mA
Output Data—Differential ³	V _{OUTp-p}	370	2000	mVp-p
Data Output Rise/Fall Time	t _R /t _F	—	220	ps
Loss-of-Signal Voltage Level	V _{LOSH} V _{LOSL}	V _{CC} - 1.3 0	V _{CC} 0.8	V V
Loss-of-Signal Assert Time ⁴	t _{loss_on}	—	100	μs
Loss-of-Signal Deassert Time ⁵	t _{loss_off}	—	100	μs
Loss of Signal Assert	P _{LOSA}	-34	-17.5	dBm
Deassert	P _{LOSD}	-34	-17	dBm
LOS Hysteresis	PHYS	0.5	6	dB

1. 2⁷ - 1 PRBS with a BER of 1 x 10⁻¹².

2. The stressed receiver sensitivity is measured using the conformance test signal defined in 802.3z, section 38.6.11.

3. Differential operation is necessary for optimum performance.

4. Time from LOS state to Rx LOS assert.

5. Time from nonLOS state to Rx LOS deassert.

Power Supply Information

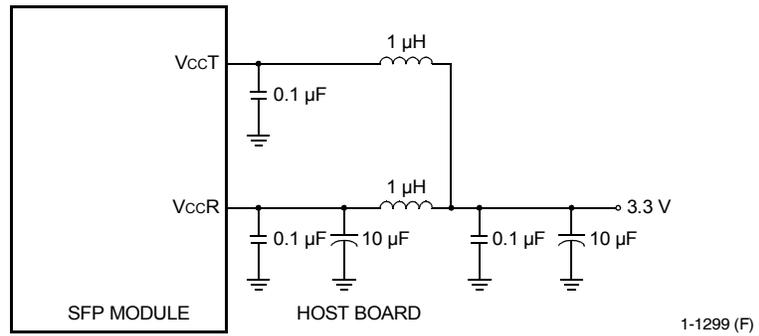


Figure 1. Power Supply Filtering of NLP12 SFP Transceiver

Pin Information

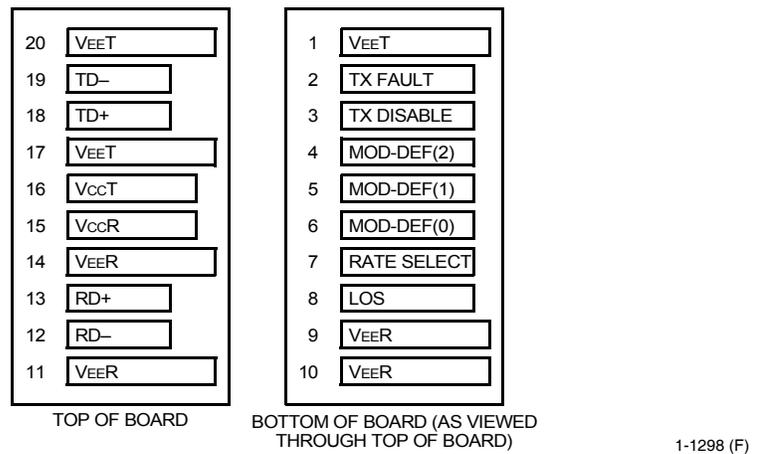


Figure 2. NLP12 SFP Transceiver, 20-Pin Configuration, Top View

Pin Information (continued)

Table 7. Transceiver Pin Descriptions

Pin Number	Symbol	Functional Description	Plug Sequence	Notes
1	VeeT	Transmitter Ground	1	—
2	TX Fault	Transmitter Fault Indication	3	See Note 1.
3	TX Disable	Transmitter Disable	3	See Note 2, Module Disables on High or Open
4	MOD-DEF2	Module Definition 2	3	See Note 3, Two-Wire Serial ID Interface
5	MOD-DEF1	Module Definition 1	3	See Note 3, Two-Wire Serial ID Interface
6	MOD-DEF0	Module Definition 0	3	See Note 3, Grounded in Module
7	Rate Select	Select Between Full or Reduced Receiver Bandwidth	3	See Note 4.
8	LOS	Loss of Signal	3	See Note 5.
9	VEER	Receiver Ground	1	See Note 6.
10	VEER	Receiver Ground	1	See Note 6.
11	VEER	Receiver Ground	1	See Note 6.
12	RD-	Inv. Received Data Out	3	See Note 7.
13	RD+	Received Data Out	3	See Note 7.
14	VEER	Receiver Ground	1	See Note 6.
15	VCCR	Receiver Power	2	See Note 8.
16	VcCT	Transmitter Power	2	See Note 8.
17	VEET	Transmitter Ground	1	See Note 6.
18	TD+	Transmit Data In	3	See Note 9.
19	TD-	Inv. Transmit Data In	3	See Note 9.
20	VEET	Transmitter Ground	1	See Note 6.

1. TX_Fault is an open collector/drain output, which should be pulled up with a 4.7 k Ω –10 k Ω resistor on the host board. Pull-up voltage between 2.0 V and VccT, R + 0.3 V. When high, output indicates a laser fault of some kind. Low indicates normal operation. In the low state, the output will be pulled to < 0.8 V.
2. TX_Disable is an input that is used to shut down the transmitter optical output. It is pulled up within the module with a 4.7 k Ω –10 k Ω resistor. Its states are as follows:
 - Low (0 V–0.8 V): transmitter on; (>0.8 V, < 2.0 V): undefined.
 - High (2.0 V–3.465 V): transmitter disabled.
 - Open: transmitter disabled.
3. MOD-DEF 0, 1, 2. These are the module definition pins. They should be pulled up with a 4.7 k Ω –10 k Ω resistor on the host board. The pull-up voltage will be VccT or VccR:
 - MOD-DEF 0 is grounded by the module to indicate that the module is present.
 - MOD-DEF 1 is the clock line of two-wire serial interface for serial ID.
 - MOD-DEF 2 is the data line of two-wire serial interface for serial ID.
4. The rate-select option is not implemented. This pin should not be connected on the host board.
5. LOS (loss of signal) is an open collector/drain output, which should be pulled up with a 4.7 k Ω –10 k Ω resistor. Pull-up voltage between 2.0 V and VccT, R + 0.3 V. When high, this output indicates the received optical power is below the worst-case receiver sensitivity (as defined by the standard in use). Low indicates normal operation. In the low state, the output will be pulled to < 0.8 V.
6. VEEr and VEEt may be internally connected within the SFP module.
7. RD-/+ : These are the differential receiver outputs. They are ac-coupled 100 Ω differential lines, which should be terminated with 100 Ω (differential) at the user SERDES. The ac coupling is done inside the module and is thus not required on the host board.
8. VccR and VcCT are the receiver and transmitter power supplies. When the recommended supply filtering network is used, hot plugging of the SFP transceiver module will result in an inrush current of no more than 30 mA greater than the steady state value. VccR and VcCT may be internally connected within the SFP transceiver module.
9. TD-/+ : These are the differential transmitter inputs. They are ac-coupled, differential lines with 100 Ω differential termination inside the module. The ac coupling is done inside the module and is thus not required on the host board.

Electrical Schematic

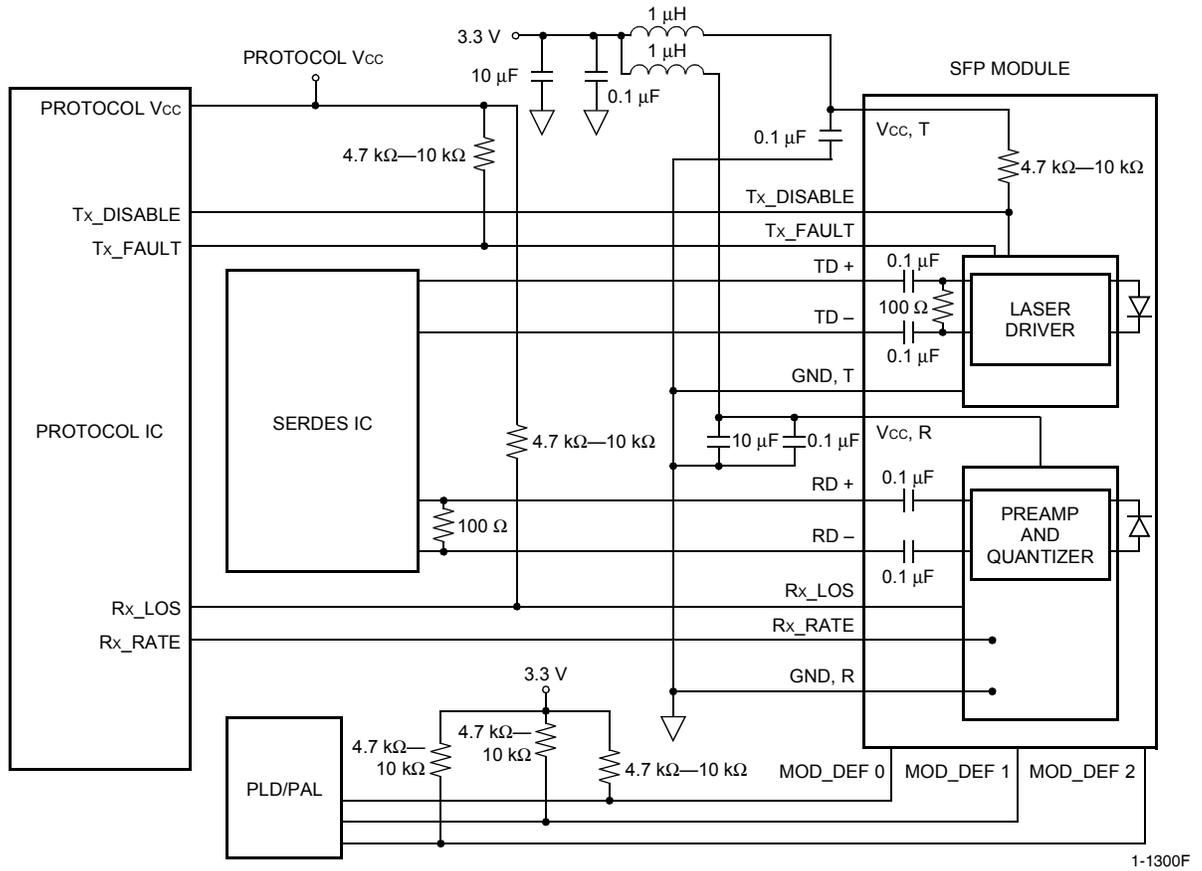


Figure 3. Example SFP Host Board Schematic

Transceiver Timing Characteristics

Table 8. Transceiver Timing Characteristics

Parameter	Symbol	Condition	Min	Max	Unit
Time to Initialize, Including Reset of Tx_Fault	t_init	— ¹	—	300	ms
Serial ID Clock Rate	f-serial-clock	—	—	100	kHz

1. Condition: from power on or negation of Tx_Fault using Tx_Disable.

Transceiver Timing Characteristics

(continued)

Module installed except where noted.

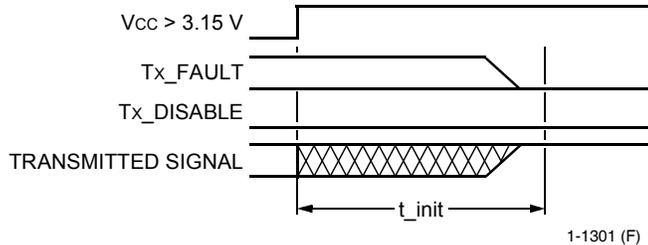


Figure 4. t_{init}: Tx_DISABLE Negated

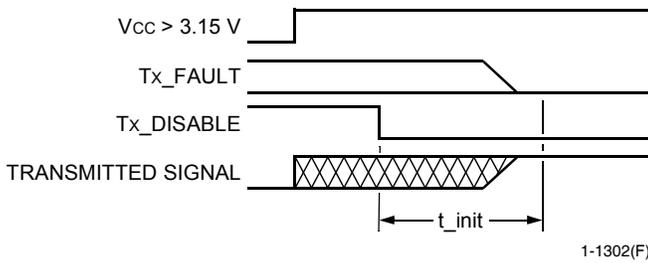


Figure 5. t_{init}: Tx_DISABLE Asserted

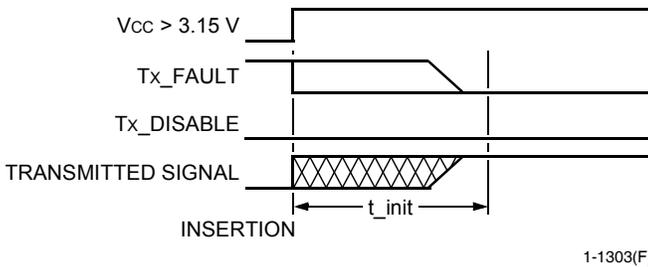


Figure 6. t_{init}: Tx_DISABLE Negated Module Hot Plugged

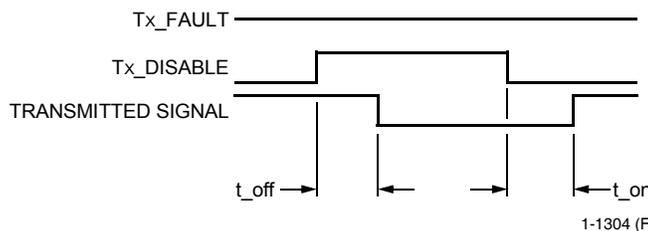


Figure 7. t_{off} and t_{on}: Tx_DISABLE Asserted Then Negated

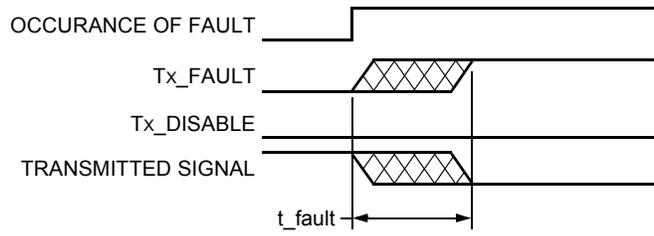
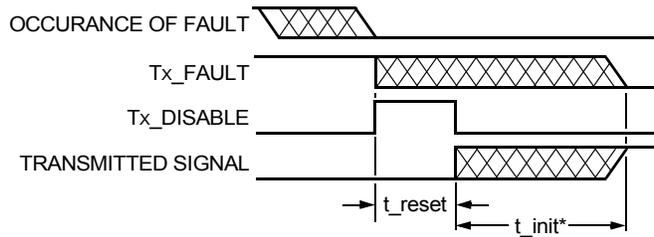
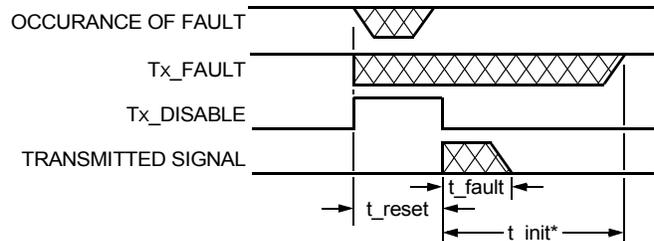


Figure 8. t_{fault}: Tx_FAULT Asserted, Tx Signal Not Recovered



* SFP will clear Tx_FAULT IN <t_{init} if the failure is transient.

Figure 9. t_{reset}: Tx Disable Asserted Then Negated, Tx Signal Recovered



* SFP will clear Tx_FAULT IN <t_{init} if the failure is transient.

Figure 10. t_{fault}: Tx Disable Asserted Then Negated, Tx Signal Not Recovered

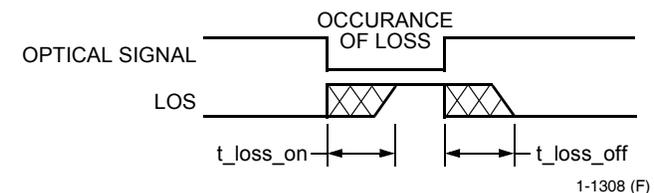


Figure 11. t_{loss_on} and t_{loss-off}

EEPROM Information

Table 9. EEPROM Serial ID Memory Contents, 1000BASE-LX Version

Address	Hex	ASCII	Address	Hex	ASCII	Address	Hex	Address	Hex
0	3	—	34	20	—	68	Note 1	98	Note 4
1	4	—	35	20	—	69	Note 1	99	Note 4
2	7	—	36	0	—	70	Note 1	100	Note 4
3	0	—	37	0	—	71	Note 1	101	Note 4
4	0	—	38	0	—	72	Note 1	102	Note 4
5	0	—	39	0	—	73	Note 1	103	Note 4
6	2	—	40	4E	N	74	Note 1	104	Note 4
7	0	—	41	4C	L	75	Note 1	105	Note 4
8	0	—	42	50	P	76	Note 1	106	Note 4
9	0	—	43	31	1	77	Note 1	107	Note 4
10	0	—	44	32	2	78	Note 1	108	Note 4
11	1	—	45	2D	—	79	Note 1	109	Note 4
12	0D	—	46	31	1	80	Note 1	110	Note 4
13	0	—	47	30	0	81	Note 1	111	Note 4
14	0A	—	48	2D	—	82	Note 1	112	Note 4
15	64	—	49	41	A	83	Note 1	113	Note 4
16	0	—	50	41	A	84	Note 2	114	Note 4
17	0	—	51	20	—	85	Note 2	115	Note 4
18	0	—	52	20	—	86	Note 2	116	Note 4
19	0	—	53	20	—	87	Note 2	117	Note 4
20	41	A	54	20	—	88	Note 2	118	Note 4
21	47	G	55	20	—	89	Note 2	119	Note 4
22	45	E	56	Note 5	—	90	20	120	Note 4
23	52	R	57	Note 5	—	91	20	121	Note 4
24	45	E	58	Note 5	—	92	0	122	Note 4
25	20	—	59	Note 5	—	93	0	123	Note 4
26	53	S	60	0	—	94	0	124	Note 4
27	59	Y	61	0	—	95	Note 3	125	Note 4
28	53	S	62	0	—	96	Note 4	126	Note 4
29	54	T	63	Note 3	—	97	Note 4	127	Note 4
30	45	E	64	0	—				
31	4D	M	65	1A	—				
32	53	S	66	0	—				
33	20	—	67	0	—				

1. Addresses 68—83 specify a unique device serial number.
2. Addresses 84—91 specify the date code in the form of two-digit year, two-digit month, and two-digit day of the month.
3. Addresses 63 and 95 are checksums. Address 63 is the checksum for bytes 0—62, and address 95 is the checksum for bytes 64—94.
4. MSA-defined, vendor-specific data, read only.
5. Addresses 56—59 specify module revision level.

EEPROM Information (continued)

Table 10. EEPROM Serial ID Memory Contents, 1000BASE-SX Version

Address	Hex	ASCII	Address	Hex	ASCII	Address	Hex	Address	Hex
0	3	—	34	20	—	68	Note 1	98	Note 4
1	4	—	35	20	—	69	Note 1	99	Note 4
2	7	—	36	0	—	70	Note 1	100	Note 4
3	0	—	37	0	—	71	Note 1	101	Note 4
4	0	—	38	0	—	72	Note 1	102	Note 4
5	0	—	39	0	—	73	Note 1	103	Note 4
6	1	—	40	4E	N	74	Note 1	104	Note 4
7	0	—	41	4C	L	75	Note 1	105	Note 4
8	0	—	42	50	P	76	Note 1	106	Note 4
9	0	—	43	31	1	77	Note 1	107	Note 4
10	0	—	44	32	2	78	Note 1	108	Note 4
11	1	—	45	2D	—	79	Note 1	109	Note 4
12	0D	—	46	30	0	80	Note 1	110	Note 4
13	0	—	47	31	1	81	Note 1	111	Note 4
14	0	—	48	2D	—	82	Note 1	112	Note 4
15	0	—	49	41	A	83	Note 1	113	Note 4
16	1B	—	50	41	A	84	Note 2	114	Note 4
17	37	—	51	20	—	85	Note 2	115	Note 4
18	0	—	52	20	—	86	Note 2	116	Note 4
19	0	—	53	20	—	87	Note 2	117	Note 4
20	41	A	54	20	—	88	Note 2	118	Note 4
21	47	G	55	20	—	89	Note 2	119	Note 4
22	45	E	56	Note 5	—	90	20	120	Note 4
23	52	R	57	Note 5	—	91	20	121	Note 4
24	45	E	58	Note 5	—	92	0	122	Note 4
25	20	—	59	Note 5	—	93	0	123	Note 4
26	53	S	60	0	—	94	0	124	Note 4
27	59	Y	61	0	—	95	Note 3	125	Note 4
28	53	S	62	0	—	96	Note 4	126	Note 4
29	54	T	63	Note 3	—	97	Note 4	127	Note 4
30	45	E	64	0	—				
31	4D	M	65	1A	—				
32	53	S	66	0	—				
33	20	—	67	0	—				

1. Addresses 68—83 specify a unique device serial number.
2. Addresses 84—91 specify the date code in the form of two-digit year, two-digit month, and two-digit day of the month.
3. Addresses 63 and 95 are checksums. Address 63 is the checksum for bytes 0—62, and address 95 is the checksum for bytes 64—94.
4. MSA-defined, vendor-specific data, read only.
5. Addresses 56—59 specify module revision level.

Electrostatic Discharge

Caution: This device is susceptible to damage as a result of electrostatic discharge (ESD). Take proper precautions during both handling and testing. Follow *EIA*® Standard *EIA-625*.

Although protection circuitry is designed into the device, take proper precautions to avoid exposure to ESD.

Agere Systems employs a human-body model (HBM) for ESD susceptibility testing and protection-design evaluation. ESD voltage thresholds are dependent on the critical parameters used to define the model. A standard HBM (resistance = 1.5 kΩ, capacitance = 100 pF) is widely used and, therefore, can be used for comparison purposes. The HBM ESD threshold established for the NLP12 is ±1000 V.

Qualification and Reliability

To help ensure high product reliability and customer satisfaction, Agere Systems is committed to an intensive quality program that starts in the design phase and proceeds through the manufacturing process. Optoelectronic modules are qualified to Agere Systems' internal standards as well as other appropriate industry standards using MIL-STD-883 test methods and procedures, and using sampling techniques consistent with *Telcordia Technologies*™ requirements.

In addition, Agere Systems has been certified to be in full compliance with the latest *ISO*® 9001 Quality System Standards.

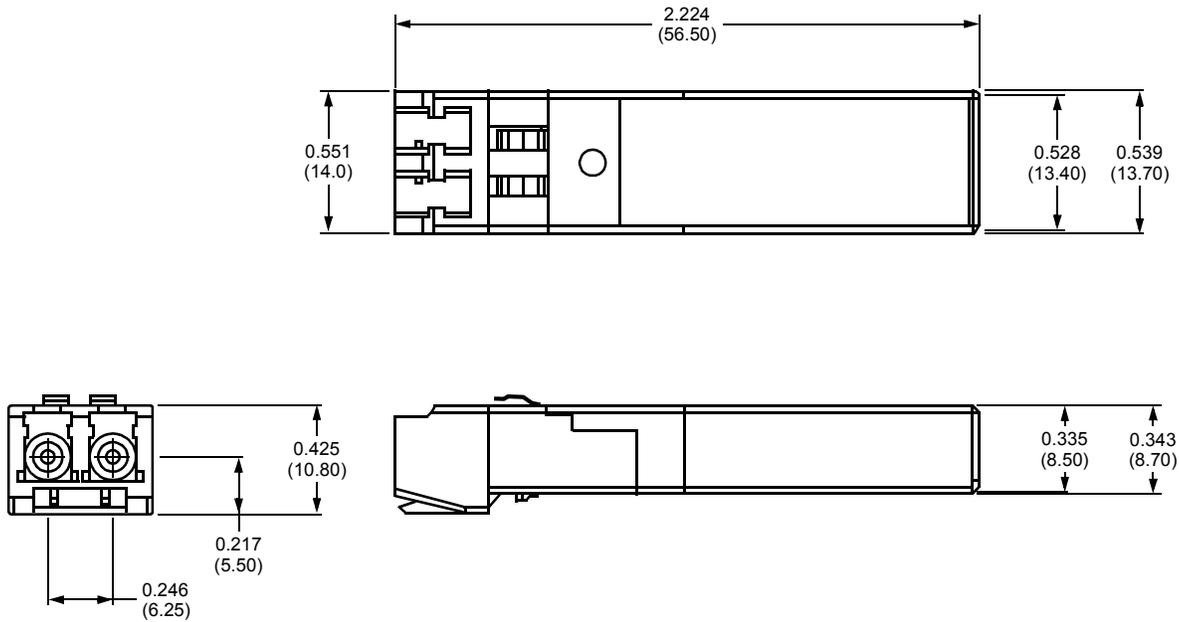
Table 11. Regulatory Compliance

Feature	Test Method	Performance
Laser Eye Safety	U.S. 21 CFR (J) 1040.10 and 1040.11, <i>IEC</i> ® 60825-1 1988, <i>IEC</i> 60825-2 1997	CDRH compliant and Class 1 laser safe. FDA Accession Number 0121593-02 (NLP12-10)
Electrostatic Discharge (ESD) to Electrical Pins	MIL-STD 883C, Method 3015.4	Class 1 (> 1000 V)
Electrostatic Discharge (ESD) to Optical Connector	<i>IEC</i> 61000-4-2; 1999	Withstand discharges of 15 kV using a human-body model probe
Electromagnetic Interference (EMI)	FCC Part 15 Subpart J Class B, CISPR 22: 1997, EN 55022: 1998 Class B, VCCI Class I	Compliant with standards
Immunity	<i>IEC</i> 61000-4-3-1998	Less than 1 dB change in receiver sensitivity with field strength of 3 V/m RMS, from 10 MHz to 1 GHz.
Component	<i>UL</i> ® 1950, CSA C22.2 #950, <i>IEC</i> 60950: 1999	—
Flammability	<i>UL</i> 94 V-0	—

Outline Drawings

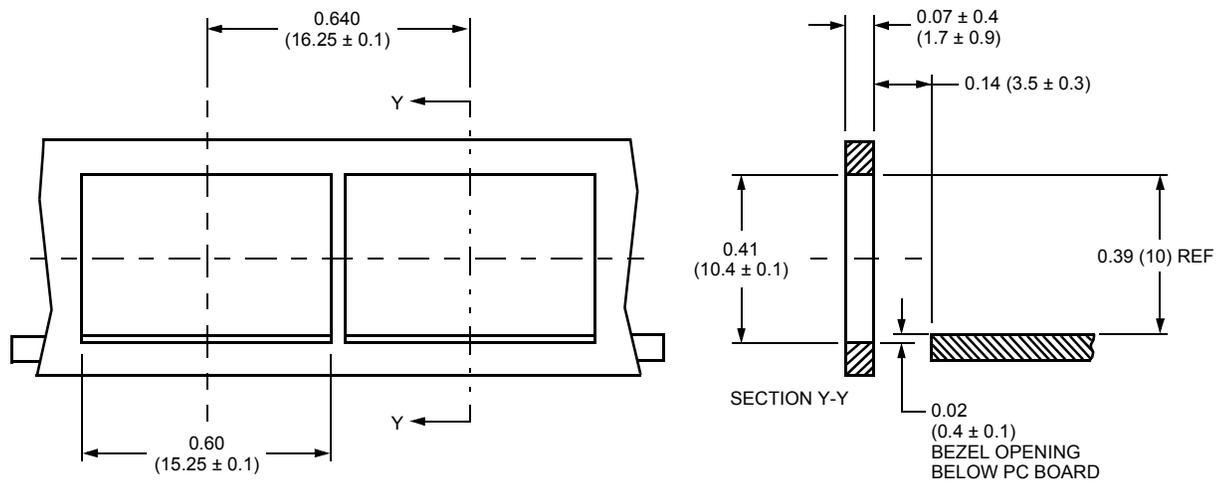
Dimensions are in inches and (millimeters).

Package Outline



1-1312 (F)

Recommended Panel Opening

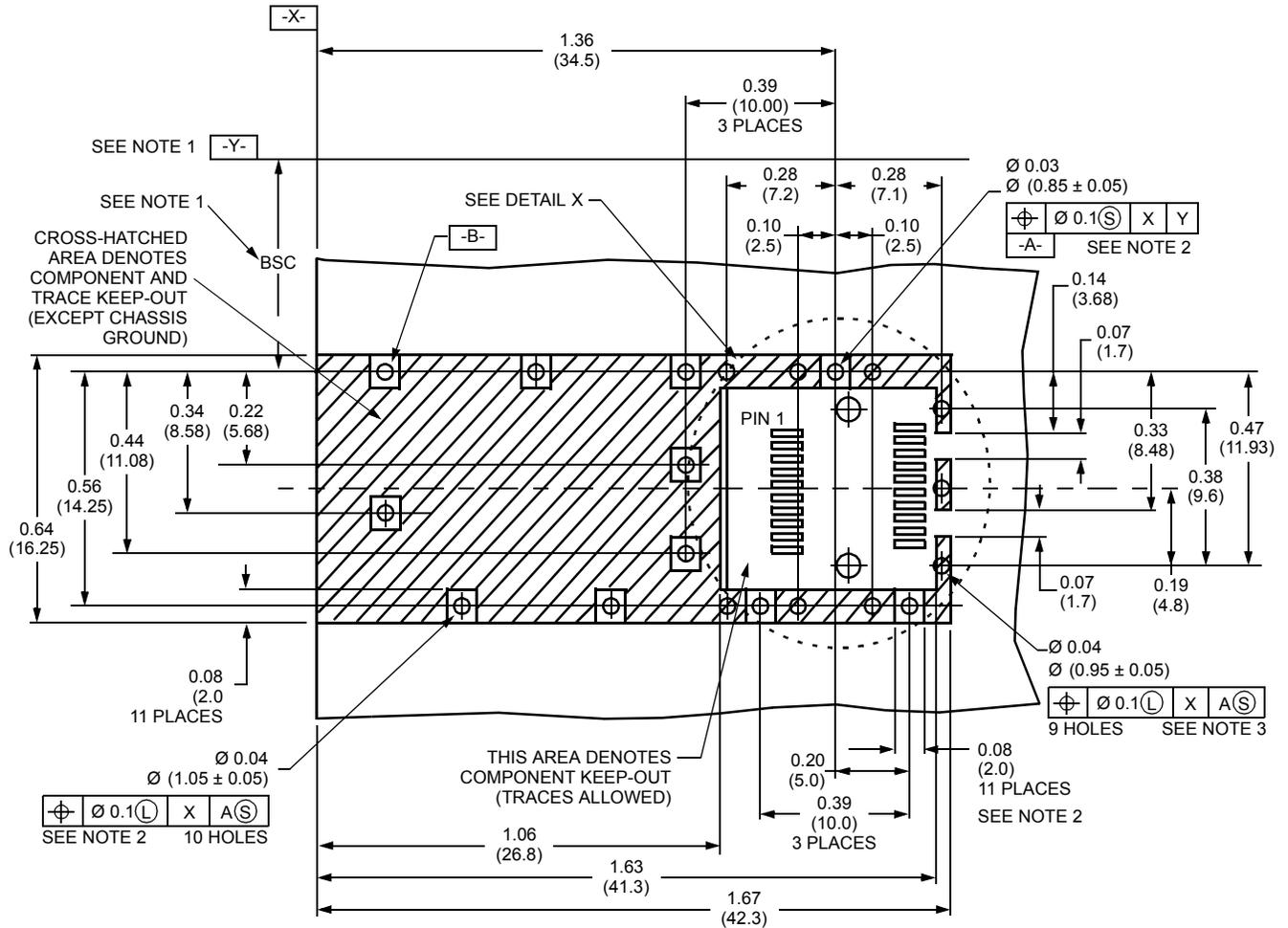


1-1309 (F)

Outline Drawings (continued)

Dimensions are in inches and (millimeters).

Printed Wiring Board Layout



1-1311F

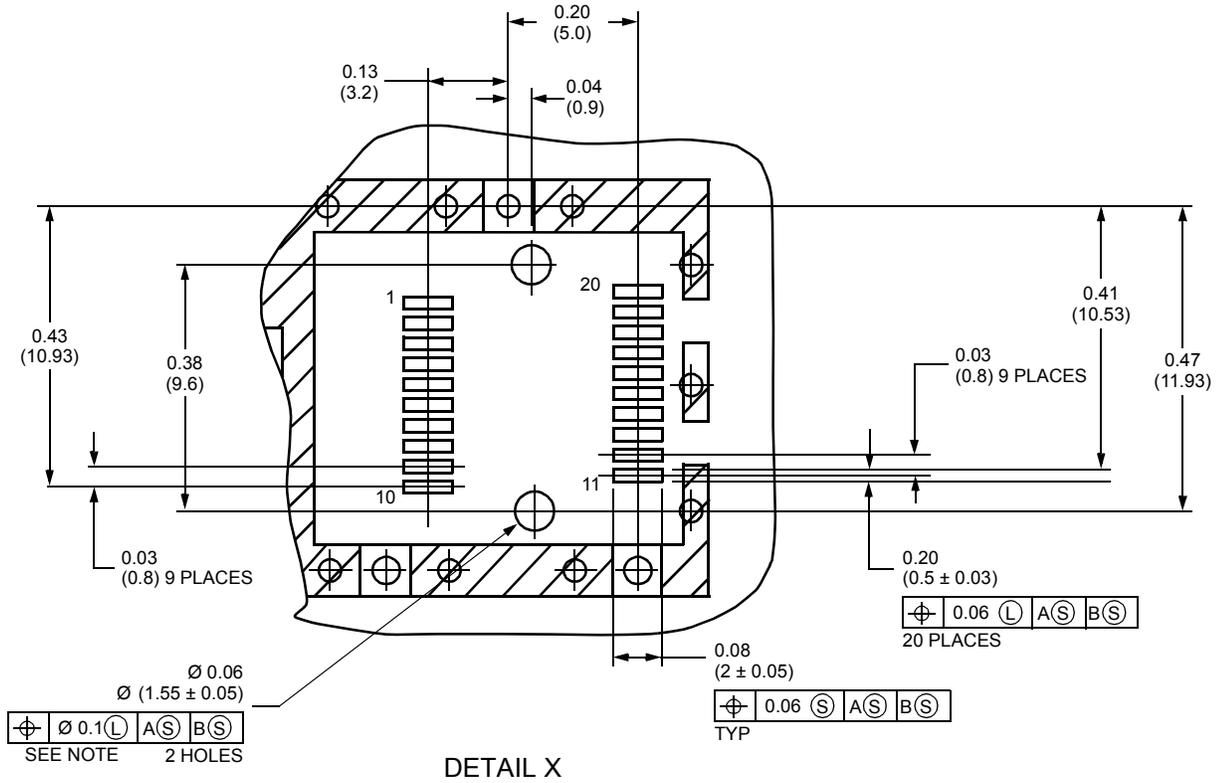
Notes:

1. Datum and basic dimensions established by customer.
2. Pads and vias are chassis ground.
3. Through holes, plating optional.

Outline Drawings (continued)

Dimensions are in inches and (millimeters).

Printed-Wiring Board Layout (continued)



1-1310F

Note: Through holes, plating optional.

Laser Safety Information

Class I Laser Product

All versions of the transceiver are Class I laser products per CDRH, 21 CFR 1040 Laser Safety requirements. All versions are Class I laser products per IEC 825-1:1993. The transceiver will be classified with the FDA under Accession Number 0121593-02 (NLP12-10).

CAUTION: Use of controls, adjustments, and procedures other than those specified herein may result in hazardous laser radiation exposure.

This product complies with 21 CFR 1040.10 and 1040.11.

Wavelength = 1310 nm (1000BASE-LX version)

Wavelength = 850 nm (1000BASE-SX version)

Maximum power = 1.58 mW

Because of size constraints, laser safety labeling is not affixed to the module but is attached to the outside of the shipping carton.

Product is not shipped with power supply.

Notice
Unterminated optical receptacles may emit laser radiation.
Do not view with optical instruments.

Ordering Information

Description	Device Code	Comcode
SFP LC Receptacle Transceiver for 1.25 Gbits/s 5 km 1000BASE-LX applications	NLP12-10-AA	700010638
SFP LC Receptacle Transceiver for 1.25 Gbits/s 550 m 1000BASE-SX applications	NLP12-01-AA	700016894

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Telcordia Technologies is a trademark of Telcordia Technologies, Inc.

ISO is a registered trademark of The International Organization for Standardization.

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